


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519267	<b>Applicant(s)/Patent Under Reexamination</b>  DICKSON ET AL.
	<b>Examiner</b>  Christopher L Chin	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Sequence search done by STIC	10/9/08	CC
EAST search	10/14/08	CC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--